



### Low-Voltage, 4:1 Mux/Demux with Low-Swing Control Inputs

#### **Features**

- → CMOS Technology for Analog Applications
- → Low-swing control inputs
- → Low On-Resistance
- → Wide V<sub>DD</sub> Range: 1.8V to 3.3V
- → Rail-to-Rail Signal Range
- → Near zero propagation delay
- → Fast Switching Speed
- → Ultra-low quiescent power
- → High Off Isolation: -95dB @ 100kHz
- → Crosstalk Rejection Reduces Signal Distortion: -90dB @ 100kHz
- → Packaging (Pb-free & Green):
  - -10-contact TQFN (1.6×1.3)

#### Truth Table(1)

Enable	Select		Function
EN	S <sub>1</sub>	$S_0$	runction
L	X	X	Y=A <sub>x</sub> , Hi-Z
Н	L	L	$Y = A_0; A_1, A_2, A_3 = Hi-Z$
Н	L	Н	$Y = A_1; A_0, A_2, A_3 = Hi-Z$
Н	Н	L	$Y = A_2; A_{0}, A_{1}, A_3 = Hi-Z$
Н	Н	Н	$Y = A_3; A_{0}, A_{1}, A_2 = Hi-Z$

### **Pin Description**

Pin Name	Description
$A_N$	Data I/O
S <sub>0-1</sub>	Select Inputs
EN	Enable
Y	Data I/O Common
GND	Ground
$V_{DD}$	Power

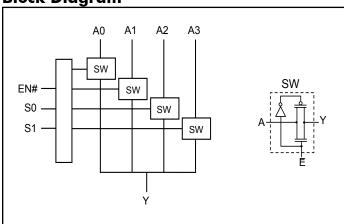
### **Description**

Diodes' PI3A114-A is a one-to-four bidirectional multiplier-demultiplier. Specified over a wide operating power supply voltage of 1.8 to 3.3V, the PI3A114-A offer good signal linearity.

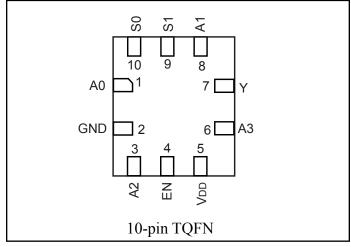
The PI3A114-A offers low-swing input voltage on the EN, S1 and S0 inputs allowing the device to operate at 3.3V, and pass 3.3V channel data, while being controlled from a 1.8V device.

**Block Diagram** 

1



# Pin Configuration (top view)







## Absolute Maximum Ratings(1)

Supply Voltage V <sub>DD</sub>	0.5V to 4.2V
Control Input Voltage (VINx)	0V to 5V
DC Input Voltage (V <sub>INPUT</sub> ) <sup>(2)</sup>	0.5V to 4.2V
Continuous Current NO_NC_COM	
Peak Current NO_NC_COM_	
(pulsed at 1ms 50% duty cycle)	±400mA
Peak Current NO NC COM	
(pulsed at 1ms 10% duty cycle)	±500mA
Storage Temperature Range (T <sub>STG</sub> )	–65°C to +150°C
Junction Temperature under Bias (T <sub>J</sub> )	150°C
Junction Lead Temperature (T <sub>L</sub> )	
(Soldering, 10 seconds)	260°C
Power Dissipation (P <sub>D</sub> ) @ +85°C	250mW

# Recommended Operating Conditions<sup>(3)</sup>

Supply Voltage Operating ( $V_{DD}$ ) 1.8V to 3.3V $\pm 5\%$
Control Input Voltage (V <sub>IN</sub> )
Switch Input Voltage (V <sub>INPUT</sub> )0.3V to V <sub>DD</sub>
Operating Temperature $(T_A) \dots -40^{\circ}C$ to $+85^{\circ}C$
Input Rise and Fall Time (t <sub>r</sub> ,t <sub>f</sub> )
Control Input $V_{DD} = 2.3V - 3.6V \dots 0ns/V$ to $10ns/V$
Thermal Resistance ( $\theta_{JA}$ )350°C/W

### Notes:

- 1. "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied.
- 2. The input and output negative voltage ratings may be exceeded if the input and output diode current ratings are observed.
- 3. Control input must be held HIGH or LOW; it must not float.

# DC Electrical Characteristics +1.8V Supply

 $(V_{DD} = 1.8V, T_A = -40^{\circ}C \text{ to } 85^{\circ}C, \text{ unless otherwise noted.})$ 

Parameter	Description	Test Conditions	Min.	<b>Typ.</b> <sup>(2)</sup>	Max.	Units
Analog Swi	tch					
Y, Ax	Analog Signal Range		-0.3		$V_{DD}$	V
R <sub>ON</sub>	On-Resistance	$I_Y = 100 \text{mA}, V_{IN} = 0 \text{ to } V_{DD}$			9	
$\Delta R_{ m ON}$	On-Resistance Match Between Channels	$I_{Y} = 100 \text{mA}, V_{IN} = 0.5 V_{DD}$			0.6	Ω
R <sub>ONF</sub>	On-Resistance Flatness	$I_Y = 100 \text{mA}, V_{IN} = 0 \text{ to } V_{DD}$			5	
THD	Total Harmonic Distortion	Load = $100 \text{K}\Omega$ , $V_{IN}$ = $0.5 V_{DD}$ , Frequency = $20 \text{Hz}$ to $20 \text{KHz}$		0.03		%
Control Inp	uts <sup>(1)</sup>					
$V_{\mathrm{IH}}$	Input HIGH Voltage	Guaranteed Logic HIGH Level	1.5			V
$V_{\mathrm{IL}}$	Input LOW Voltage	Guaranteed Logic LOW Level	-0.5		0.8	\ \ \
I <sub>IH</sub>	Input HIGH Current	$V_{DD} = Max., V_{IN} = V_{DD}$			±1	
$I_{\mathrm{IL}}$	Input LOW Current	$V_{DD} = Max., V_{IN} = GND$			±1	μΑ
I <sub>OZH</sub>	High Impedance Output Current	$0 \le I_N, Y_N \le V_{DD}$			±1	μΑ
V <sub>IK</sub>	Clamp Diode Voltage	$V_{DD} = Min., I_{IN} = -18mA$			-1.2	V

#### Notes:

- 1. For digital control inputs EN, S0, S1.
- 2. Typical values are at  $V_{DD} = 1.8V$ ,  $T_A = 25$ °C ambient and maximum loading.
- 3. For Max. or Min. conditions, use appropriate value specified under Electrical Characteristics for the applicable device type.
- 4. Measured by the voltage drop between A and Y pin at indicated current through the switch. On-Resistance is determined by the lower of the voltages on the two (I,Y) pins.





## Power Supply Characteristics +1.8V Supply

Parameters	Description	Test Conditions <sup>(1)</sup>		Min.	<b>Typ.</b> <sup>(2)</sup>	Max.	Units
$I_{CC}$	Quiescent Power Supply Current	$V_{DD} = Max.$	$V_{IN} = GND \text{ or } V_{DD}$		0.1	9.0	μΑ

#### Notes:

- 1. Control inputs only; A and Y pins do not contribute to I<sub>CC</sub>.
- Typical values are at V<sub>DD</sub> = 1.8V, T<sub>A</sub> = 25°C ambient and maximum loading.
- 3. For Max. or Min. conditions, use appropriate value specified under Electrical Characteristics for the applicable device.

## DC Electrical Characteristics +3.3V Supply

 $(V_{DD} = 3.3V, T_A = -40^{\circ}C \text{ to } 85^{\circ}C, \text{ unless otherwise noted.})$ 

Parameter	Description	<b>Test Conditions</b>	Min.	<b>Typ</b> <sup>(2)</sup>	Max.	Units
Analog Swi	tch					
Y, Ax	Analog Signal Range		-0.3		$V_{\mathrm{DD}}$	V
R <sub>ON</sub>	On-Resistance	$I_Y = 100 \text{mA}$ , $V_{IN} = 0$ to $V_{DD}$			5	
$\Delta R_{ m ON}$	On-Resistance Match Between Channels	$I_{Y} = 100 \text{mA}, V_{IN} = 0.5 V_{DD}$			0.2	Ω
R <sub>ONF</sub>	On-Resistance Flatness	$I_Y = 100 \text{mA}$ , $V_{IN} = 0$ to $V_{DD}$			0.6	
THD	Total Harmonic Distortion	Load = $100 K\Omega$ , $V_{IN}$ = $0.5 V_{DD}$ , Frequency = $20 Hz$ to $20 KHz$		0.03		%
Control Inpu	uts <sup>(1)</sup>					
$V_{\mathrm{IH}}$	Input HIGH Voltage	Guaranteed Logic HIGH Level	1.5			V
$V_{\mathrm{IL}}$	Input LOW Voltage	Guaranteed Logic LOW Level	-0.5		0.8	V
$I_{IH}$	Input HIGH Current	$V_{DD} = Max., V_{IN} = V_{DD}$			±1	
I <sub>IL</sub>	Input LOW Current	$V_{DD} = Max., V_{IN} = GND$			±1	μΑ
I <sub>OZH</sub>	High Impedance Output Current	$0 \leq I_N,  Y_N \leq V_{DD}$			±1	μΑ
V <sub>IK</sub>	Clamp Diode Voltage	$V_{DD} = Min., I_{IN} = -18mA$			-1.2	V

#### Notes:

- 1. For digital control inputs EN, S0, S1.
- 2. For Max. or Min. conditions, use appropriate value specified under Electrical Characteristics for the applicable device.
- 2. Typical values are at  $V_{DD} = 3.3V$ ,  $T_A = 25$ °C ambient and maximum loading.
- 3. Measured by the voltage drop between A and Y pin at indicated current through the switch. On-Resistance is determined by the lower of the voltages on the two (I,Y) pins.

# **Power Supply Characteristics, 3.3V Supply**

Parameters	Description	Test	Conditions $^{(1)}$	Min.	<b>Typ.</b> <sup>(2)</sup>	Max.	Units
I <sub>CC</sub>	Quiescent Power Supply Current	$V_{DD} = Max.$	$V_{IN} = GND \text{ or } V_{DD}$		0.1	9.0	μΑ

#### **Notes:**

- 1. For Max. or Min. conditions, use appropriate value specified under Electrical Characteristics for the applicable device.
- 2. Typical values are at  $V_{DD} = 3.3V$ , +25°C ambient.
- 3. Control inputs only; A and Y pins do not contribute to I<sub>CC</sub>.





### **Switch and AC Characteristics**

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
t <sub>ON</sub>	Turn-On Time	$V_{DD}$ = 2.7V, $V_{IN}$ = 1.5V, $R_L$ = 50 $\Omega$ , $C_L$ = 35pF, See Test Circuit Figure 1 & 2.		5	15	200
t <sub>OFF</sub>	Turn-Off Time	$V_{DD}$ = 2.7V, $V_{IN}$ = 1.5V, $R_L$ = 50 $\Omega$ , $C_L$ = 35pF, See Test Circuit Figure 1 & 2.		35	50	ns
Q	Charge Injection	$COM = 0$ , $R_S = 0$ , $C_L = 1nF$ , $V_{DD} = 3.3V$ See Test Circuit Figure 4.		15		pC
O <sub>IRR</sub>	Off-Isolation	$C_L = 5 p F, R_L = 50 \Omega, f = 100 k H z,$ $V_{IN} = 1 V_{RMS}, V_{DD} = 3.3 V$ See Test Circuit Figure 5.		-95		σι
X <sub>TALK</sub>	Crosstalk	$C_L = 5 p F, R_L = 50 \Omega, f = 100 k H z,$ $V_{IN} = 1 V_{RMS}, V_{DD} = 3.3 V$ See Test Circuit Figure 6.		-90		dB
f <sub>3dB</sub>	3dB Bandwidth	See Test Circuit Figure 9., V <sub>DD</sub> = 3.3V		250		MHz
$t_{pd}^{(1)}$	Propogation delay	$C_{L} = 5 \text{pF}, R_{L} = 500 \text{km}$			0.25	ns

#### Note:

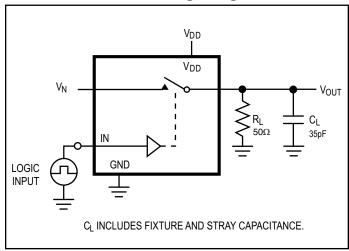
# **Capacitance**

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
C <sub>NC</sub> (OFF)	Off Capacitance	f = 1MHz, See Test Circuit Figure 7.		15		"E
C <sub>NC</sub> (ON)	On Capacitance	f = 1MHz, See Test Circuit Figure 8.		25		pF

<sup>1.</sup> This Parameter is not production tested.



# **Test Circuits and Timing Diagrams**



 $V_{DD}$ 10nF Capacitance  $V_{DD}$ Meter f = 1 MHz Logic Input 0V or V<sub>IH</sub> GND

Figure 2. AC Waveforms

Figure 1. AC Test Circuit

#### **Notes:**

Unused input (NC or NO) must be grounded.

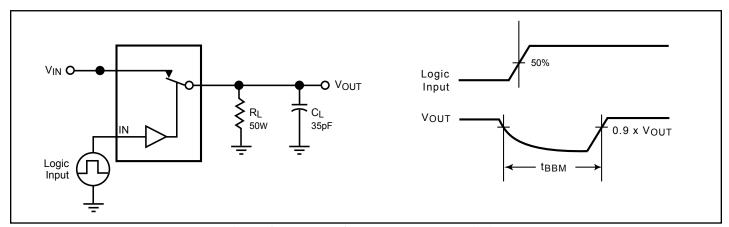


Figure 3. Break Before Make Interval Timing

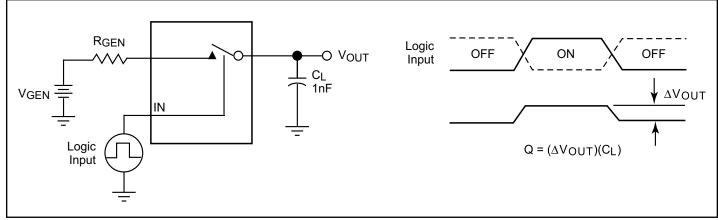


Figure 4. Charge Injection Test

5



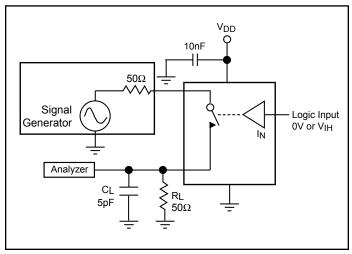


Figure 5. Off Isolation

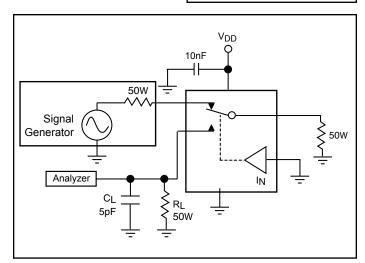


Figure 6. Crosstalk

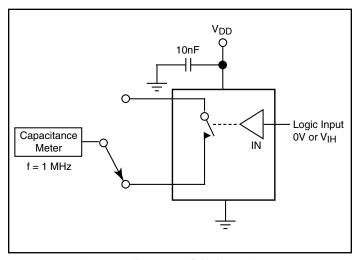


Figure 7. Channel Off Capacitance

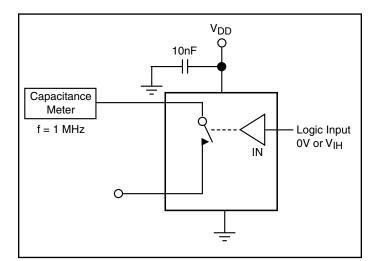


Figure 8. Channel On Capacitance

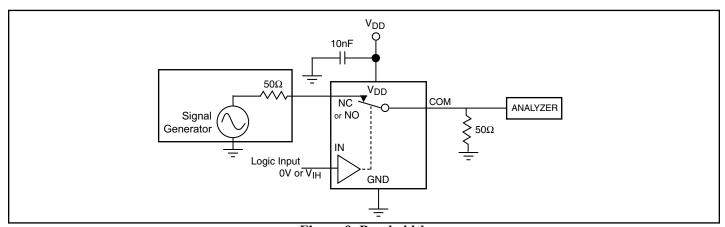
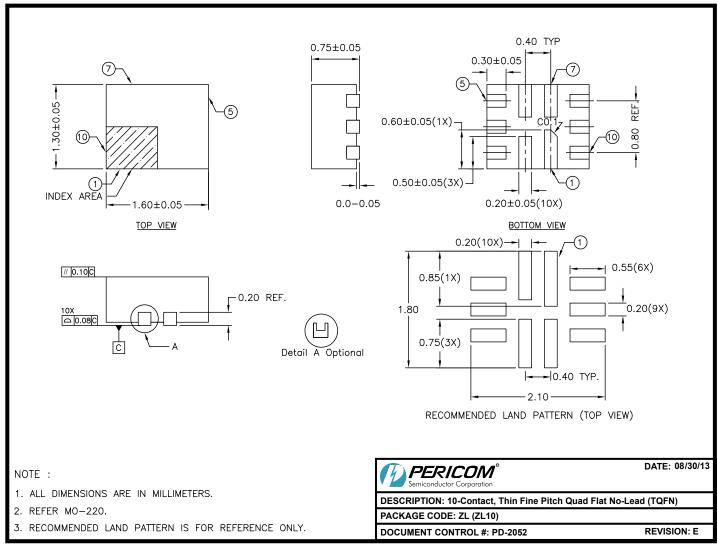


Figure 9. Bandwidth





# Packaging Mechanical: 10-pin TQFN (ZL)



13-0175

#### For latest package info.

please check: http://www.diodes.com/design/support/packaging/pericom-packaging/packaging-mechanicals-and-thermal-characteristics/

### **Ordering Information**

Ordering Code	Packaging Code	Package Type	Top Mark
PI3A114-AZLEX	ZL	10-Contact, Thin Fine Pitch Quad Flat No-Lead (TQFN)	CR

#### Notes:

- · Thermal characteristics can be found on the company web site at www.diodes.com/design/support/packaging/
- E = Pb-free and Green
- X suffix = Tape/Reel





#### IMPORTANT NOTICE

DIODES INCORPORATED MAKES NO WARRANTY OF ANY KIND, EXPRESS OR IMPLIED, WITH REGARDS TO THIS DOCUMENT, INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION).

Diodes Incorporated and its subsidiaries reserve the right to make modifications, enhancements, improvements, corrections or other changes without further notice to this document and any product described herein. Diodes Incorporated does not assume any liability arising out of the application or use of this document or any product described herein; neither does Diodes Incorporated convey any license under its patent or trademark rights, nor the rights of others. Any Customer or user of this document or products described herein in such applications shall assume all risks of such use and will agree to hold Diodes Incorporated and all the companies whose products are represented on Diodes Incorporated website, harmless against all damages.

Diodes Incorporated does not warrant or accept any liability whatsoever in respect of any products purchased through unauthorized sales channel.

Should Customers purchase or use Diodes Incorporated products for any unintended or unauthorized application, Customers shall indemnify and hold Diodes Incorporated and its representatives harmless against all claims, damages, expenses, and attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized application.

Products described herein may be covered by one or more United States, international or foreign patents pending. Product names and markings noted herein may also be covered by one or more United States, international or foreign trademarks.

This document is written in English but may be translated into multiple languages for reference. Only the English version of this document is the final and determinative format released by Diodes Incorporated.

#### LIFE SUPPORT

Diodes Incorporated products are specifically not authorized for use as critical components in life support devices or systems without the express written approval of the Chief Executive Officer of Diodes Incorporated. As used herein:

- A. Life support devices or systems are devices or systems which:
  - 1. are intended to implant into the body, or
- 2. support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labeling can be reasonably expected to result in significant injury to the user.
- B. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or to affect its safety or effectiveness.

Customers represent that they have all necessary expertise in the safety and regulatory ramifications of their life support devices or systems, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of Diodes Incorporated products in such safety-critical, life support devices or systems, notwithstanding any devices- or systems-related information or support that may be provided by Diodes Incorporated. Further, Customers must fully indemnify Diodes Incorporated and its representatives against any damages arising out of the use of Diodes Incorporated products in such safety-critical, life support devices or systems.

Copyright © 2016, Diodes Incorporated www.diodes.com